

2nd Conference on the Economics of Test and Evaluation

Overview

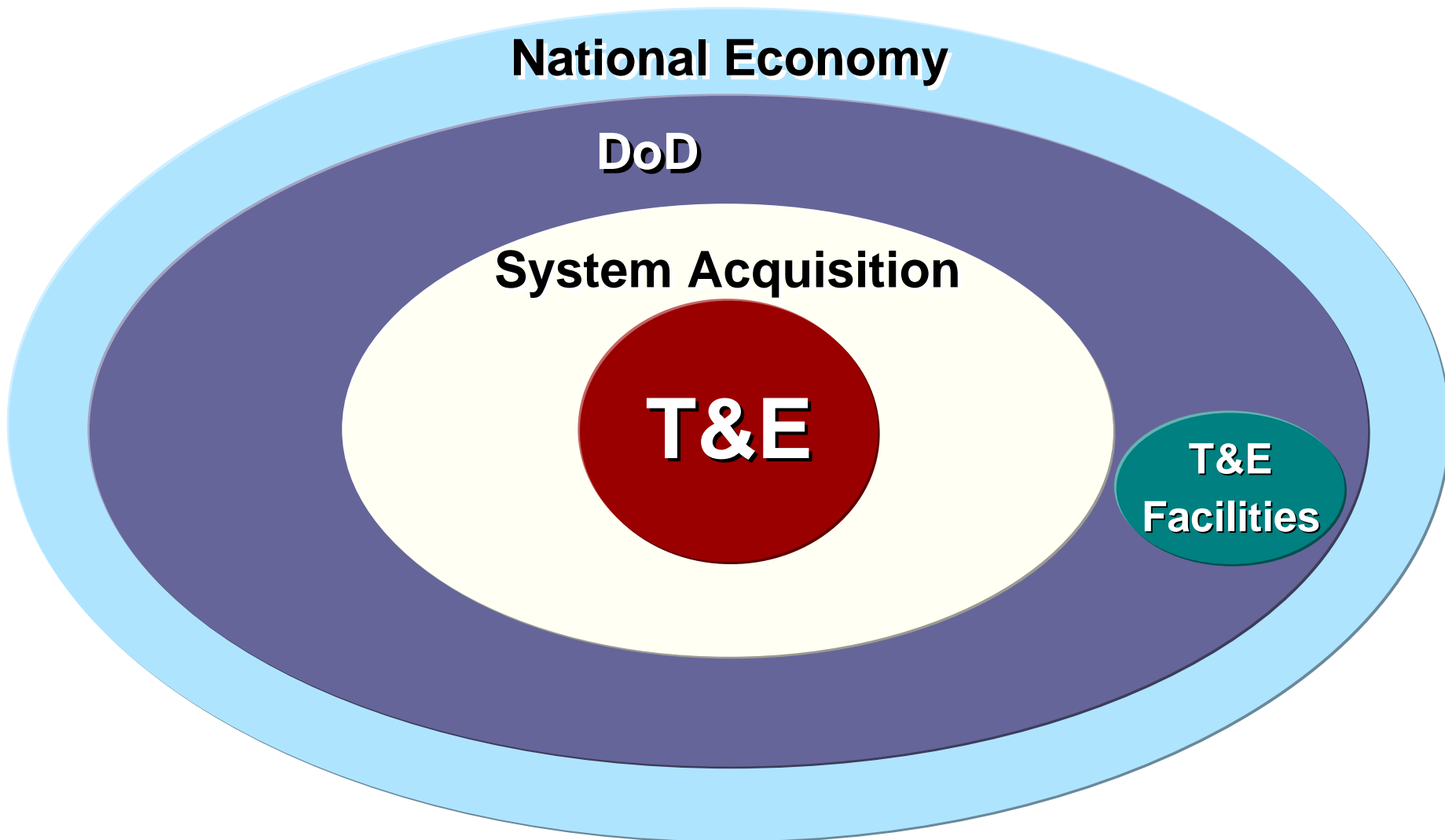
2 – 4 November 1999
Atlanta Georgia



Dr. Sam Blankenship
TEREC Director

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Economic Perspective



Benefits of T&E

- **More Effective Systems**
- **Early Identification of System Problems**
- **Support Tactics and Doctrine Development**
- **Lower Life Cycle Costs**

Whose Costs of T&E?

- **Contractor**
- **Tester**
- **System Developer**
- **Service**
- **Nation**

Tuesday, 2 November 1999

0730 On-Site Registration

**0800-1700 “Economic Analysis for Technology Decisions”,
Dr. Christine Ries,
School of Economics,
Georgia Institute of Technology**

***Basic economic thinking applied to issues such
as consolidation, outsourcing/privatization, and
facility upgrades***

Wednesday, 3 November 1999

0730	On-Site Registration	
0830	Welcome	George Harrison Georgia Institute of Technology Dr. Sam Blankenship TEREC Director
0845	Keynote Presentation “There may be no economy in cheap tests”	Dr. Ernest Seglie Science Advisor Operational T&E OSD
0930	BREAK	
1000	Conference Overview	Dr. Sam Blankenship
1015	“T&E Planning, from Mission to Test Plan”	Maj. James Przybysz AFOTEC/CN Mr. Roger Pudwill Logicon
1145	LUNCH	

Wednesday, 3 November 1999

1300	“Unified Framework for T&E Planning”	
	Program Chair:	Professor Martha Nelson Chair of Business Department Franklin and Marshall College
	Panelists:	Mr. Jack Sheehan DMSO Dr. Paul Deitz Technical Director AMSAA Mr. Bill Hacker Applied Research Associates, Inc. Dr. Ronald Luman Applied Physics Laboratory Johns Hopkins University
1530	BREAK	
1600	Technical Presentations	Prof. Christine Ries, Georgia Institute of Technology Mr. Martin Prehm NUWC
1800	SOCIAL AT HOTEL	

Thursday, 4 November 1999

0830	Welcome	Dr. Sam Blankenship Director, TEREK
0840	“Defense Science Board T&E Task Force Study Results”	Mr. Charles (Pete) Adolph SAIC
0930	BREAK	
1000	Technical Session	Dr. Nancy David, Veridan – ERIM Mr. Nick Borns, USA Developmental Test Command Mr. Michael Teems, Applied Physics Laboratory, Johns Hopkins University
1145	LUNCH	
1330	“Connecting Life Cycle Costs to T&E”	
	Panel Chair:	Dr. Art Fries Institute for Defense Analyses
	Panelists:	Mr. Waynard Devers, Institute for Defense Analyses Mr. Ronald Wagner, Georgia Tech Research Institute Georgia Institute of Technology